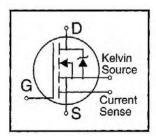
International Rectifier

IRC644PbF

HEXFET® Power MOSFET

- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- Current Sense
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Lead-Free



$$V_{DSS} = 250V$$

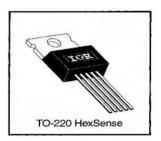
$$R_{DS(on)} = 0.28\Omega$$

$$I_{D} = 14A$$

Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The HEXSense device provides an accurate fraction of the drain current through the additional two leads to be used for control or protection of the device. These devices exhibit similar electrical and thermal characteristics as their IRF-series equivalent part numbers. The provision of a kelvin source connection effectively eliminates problems of common source inductance when the HEXSense is used as a fast, high-current switch in non current-sensing applications.



Absolute Maximum Ratings

	Parameter	Max.	Units		
I _D @ T _C = 25°C	@ T _C = 25°C Continuous Drain Current, V _{GS} @ 10 V				
Ip @ Tc = 100°C	Continuous Drain Current, V _{GS} @ 10 V	8.5	A		
I _{DM}	Pulsed Drain Current ①	56			
Pp @ Tc = 25°C	Power Dissipation	125	W		
	Linear Derating Factor	1.0	W/°C		
V _{GS}	Gate-to-Source Voltage	±20	V		
Eas	Single Pulse Avalanche Energy ②	550	mJ		
IAR	Avalanche Current ①	14	A		
EAR	Repetitive Avalanche Energy ①	13	mJ		
dv/dt	Peak Diode Recovery dv/dt ③	4.8	V/ns		
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to +150	°C		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)			
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1 N•m)			

Thermal Resistance

	Parameter	Min.	Тур.	Max.	Units
Reuc	Junction-to-Case	_	_	1.0	
Recs	Case-to-Sink, Flat, Greased Surface	-	0.50	_	°C/W
ReJA	Junction-to-Ambient	_	_	62	

IRC644PbF

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	250	-	-	٧	V _{GS} =0V, I _D = 250μA	
ΔV _{(BR)DSS} /ΔT _J	Breakdown Voltage Temp. Coefficient	_	0.37	-	V/°C	Reference to 25°C, ID= 1mA	
Ros(on)	Static Drain-to-Source On-Resistance	-	_	0.28	Ω	V _{GS} =10V, I _D =8.4A ④	
V _{GS(th)}	Gate Threshold Voltage	2.0	_	4.0	٧	V _{DS} =V _{GS} , I _D = 250μA	
g _{fs}	Forward Transconductance	6.6	_	-	S	V _{DS} =50V, I _D =8.4A ④	
less	Built to Comment to the second	-	-	25		V _{DS} =250V, V _{GS} =0V	
loss	Drain-to-Source Leakage Current	_	-	250	μА	V _{DS} =200V, V _{GS} =0V, T _J =125°C	
Const	Gate-to-Source Forward Leakage	-	-	100	nA	V _{GS} =20V	
less	Gate-to-Source Reverse Leakage	_	-	-100	IIA	V _{GS} =-20V	
Q_9	Total Gate Charge	-	-	65		I _D =14A	
Qgs	Gate-to-Source Charge	-	-	11	nC	V _{DS} =200V	
Q _{gd}	Gate-to-Drain ("Miller") Charge	_	_	32		V _{GS} =10V See Fig. 6 and 13 ④	
t _{d(on)}	Turn-On Delay Time	-	12	-		V _{DD} =125V	
tr	Rise Time	-	37	-	ns	I _D =14A	
td(off)	Turn-Off Delay Time	-	49	-	113	R _G =9.1Ω	
tı	Fall Time	_	29	-		R _D =8.7Ω See Figure 10 @	
Lo	Internal Drain Inductance	-	4.5	-	nН	Between lead, 6 mm (0.25in.) from package and center of die contact	
Ls	Internal Source Inductance	-	7.5	-			
Ciss	Input Capacitance	-	1200	_		V _{GS} =0V	
Coss	Output Capacitance	1-	310	_	pF	V _{DS} =25V	
Crss	Reverse Transfer Capacitance	-	90	-		f=1.0MHz See Figure 5	
r	Current Sensing Ratio	2630	_	2900	-	I _D =14A, V _{GS} =10V	
Coss	Output Capacitance of Sensing Cells	_	9.0	-	pF	V _{GS} =0V, V _{DS} = 25V, f=1.0MHz	

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Is	Continuous Source Current (Body Diode)	-	-	14	A	MOSFET symbol showing the
Ism	Pulsed Source Current (Body Diode) ①	-	-	56	^	integral reverse p-n junction diode.
V _{SD}	Diode Forward Voltage	_	_	1.8	٧	T _J =25°C, I _S =14A, V _{GS} =0V @
trr	Reverse Recovery Time	_	310	670	ns	T _J =25°C, I _F =14A
Qrr	Reverse Recovery Charge	-	3.5	7.3	μC	di/dt=100A/μs ④
ton	Forward Turn-On Time	Intrinsic turn-on time is neglegible (turn-on is dominated by Ls+LD)				

Notes:

- Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ③ Isp≤14A, di/dt≤150A/ μ s, Vpp≤V(BR)pss, TJ≤150°C
- $V_{DD}=50V,$ starting $T_{J}=25$ °C, L=4.50mH $R_{G}=25Ω,$ $I_{AS}=14A$ (See Figure 12)
- 4 Pulse width \leq 300 μ s; duty cycle \leq 2%.

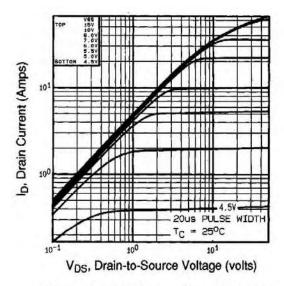


Fig 1. Typical Output Characteristics, Tc=25°C

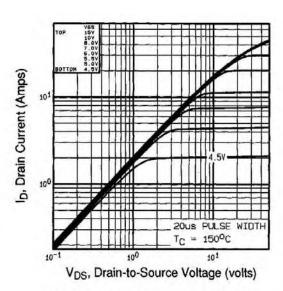


Fig 2. Typical Output Characteristics, Tc=150°C

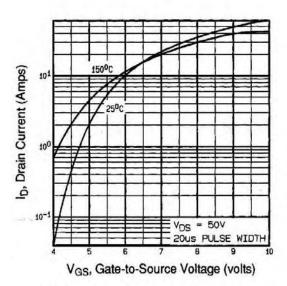


Fig 3. Typical Transfer Characteristics

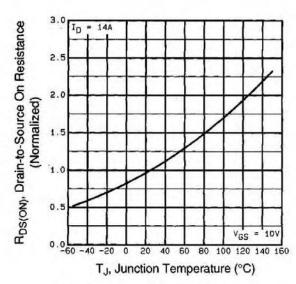


Fig 4. Normalized On-Resistance Vs. Temperature

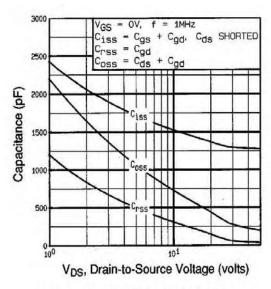


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

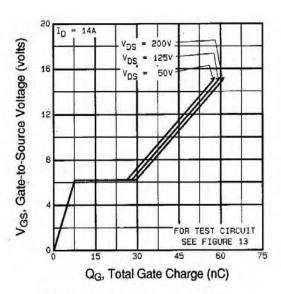


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

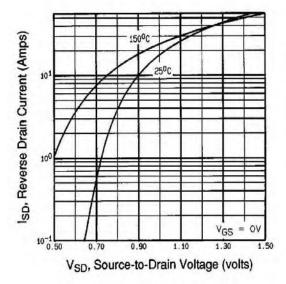


Fig 7. Typical Source-Drain Diode Forward Voltage

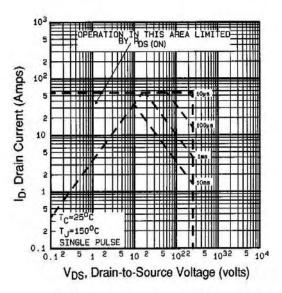


Fig 8. Maximum Safe Operating Area

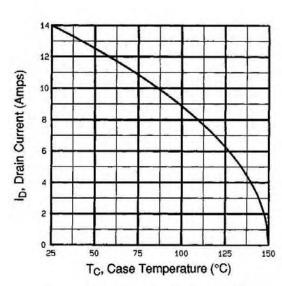


Fig 9. Maximum Drain Current Vs. Case Temperature

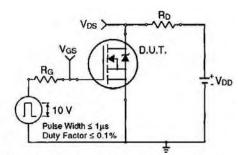


Fig 10a. Switching Time Test Circuit

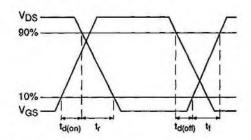


Fig 10b. Switching Time Waveforms

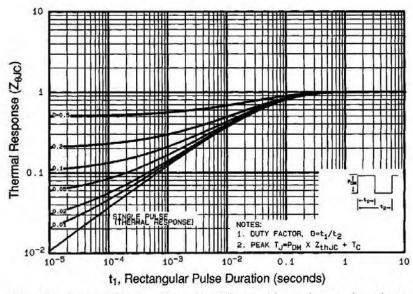


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

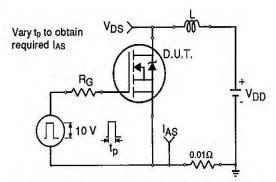


Fig 12a. Unclamped Inductive Test Circuit

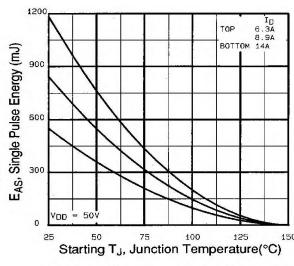


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

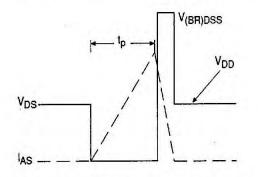


Fig 12b. Unclamped Inductive Waveforms

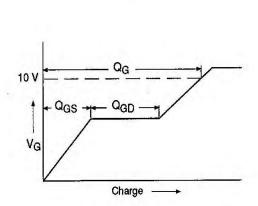


Fig 13a. Basic Gate Charge Waveform

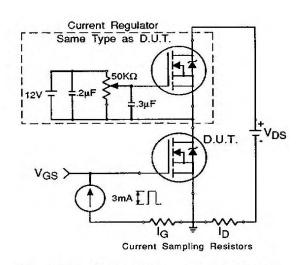


Fig 13b. Gate Charge Test Circuit

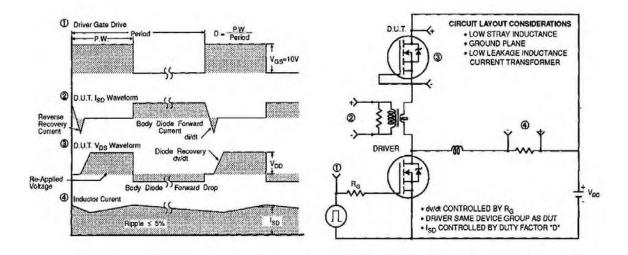


Fig 14. Peak Diode Recovery dv/dt Test Circuit

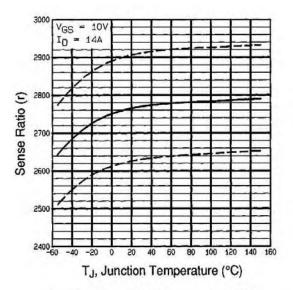


Fig 15. Typical HEXSense Ratio Vs. Junction Temperature

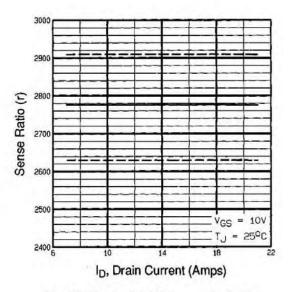


Fig 16. Typical HEXSense Ratio Vs. Drain Current

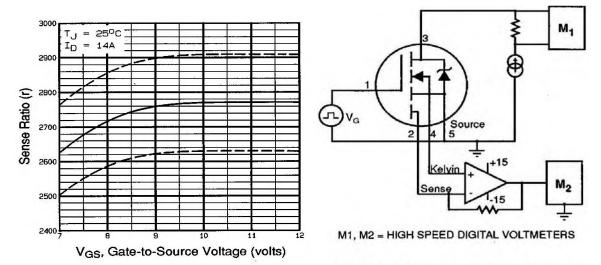


Fig 17. Typical HEXSense Ratio Vs. Gate Voltage

Fig 18. HEXSense Ratio Test Circuit

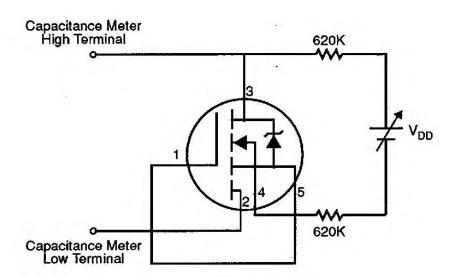


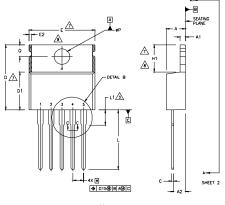
Fig 19. HEXSense Sensing Cell Output Capacitance Test Circuit

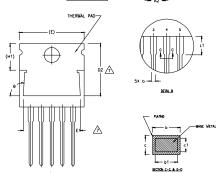
International Rectifier

IRC644PbF

Hexsense TO-220 5L Package Outline

(Dimensions are shown in millimeters (inches)





- DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- DIMENSIONING AND IDLERANCING PER ASM. 114.5 M- 1994.

 DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].

 LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.

 DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH

 SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE

 MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- DIMENSION b1 & c1 APPLY TO BASE METAL ONLY.
 CONTROLLING DIMENSION: INCHES.
 THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.

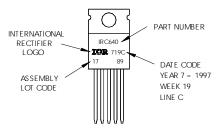
	DIMENSIONS					
SYMBOL	MILLIM	ETERS	INCHES		1	
	MIN.	MAX.	MIN.	MAX.	NOTES	
Α	3,56	4,82	,140	.190		
A1	0.51	1.40	.020	.055		
A2	2.04	2.92	.080	.115		
b	0.64	0.88	.025	.035		
b1	0.64	0.84	.025	.033	5	
С	0.36	0.61	.014	.024		
c1	0.36	0.56	.014	.022	5	
D	14,22	16,51	,560	.650	4	
D1	8.38	9.02	.330	.355		
D2	12.19	12,88	.480	.507	7	
E	9,66	10,66	.380	.420	4,7	
E1	8.38	8.89	.330	.350	7	
e	1,70	BSC	.067 BSC			
H1	5.85	6.55	.230	.270	7,8	
L	13,47	14,09	.530	.555		
L1	-	6.35	-	.250	3	
øΡ	3.54	4.08	.139	.161		
Q	2,54	3,42	.100	.135		
ø	90"-	-93*	90"	-93*		

Hexsense TO-220 5L Part Marking Information

EXAMPLE: THIS IS AN IRC640 WITH ASSEMBLY LOT CODE 1789

ASSEMBLED ON WW 19, 1997 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead-Free



Data and specifications subject to change without notice.

International IOR Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105

TAC Fax: (310) 252-7903



Vishay

Notice

The products described herein were acquired by Vishay Intertechnology, Inc., as part of its acquisition of International Rectifier's Power Control Systems (PCS) business, which closed in April 2007. Specifications of the products displayed herein are pending review by Vishay and are subject to the terms and conditions shown below.

Specifications of the products displayed herein are subject to change without notice. Vishay Intertechnology, Inc., or anyone on its behalf, assumes no responsibility or liability for any errors or inaccuracies.

Information contained herein is intended to provide a product description only. No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document. Except as provided in Vishay's terms and conditions of sale for such products. Vishay assumes no liability whatsoever, and disclaims any express or implied warranty, relating to sale and/or use of Vishay products including liability or warranties relating to fitness for a particular purpose, merchantability, or infringement of any patent, copyright, or other intellectual property right.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications. Customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Vishay for any damages resulting from such improper use or sale.

International Rectifier®, IR®, the IR logo, HEXFET®, HEXSense®, HEXDIP®, DOL®, INTERO®, and POWIRTRAIN® are registered trademarks of International Rectifier Corporation in the U.S. and other countries. All other product names noted herein may be trademarks of their respective owners.

Document Number: 99901 www.vishay.com Revision: 12-Mar-07